

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/641,372	SAED, ARYAN
Examiner	Art Unit	
Patricia T. Nguyen	2817	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
330		149		330		107	136				
INTERNATIONAL CLASSIFICATION											
H	0	3	F	1/26							
				/							
				/							
				/							
				/							
(Assistant Examiner) (Date)				PATRICIA NGUYEN PRIMARY EXAMINER Patricia Nguyen 9/18/2005				Total Claims Allowed: 50			
<i>J. Hayes</i> 9/21/05 (Legal Instruments Examiner) (Date)				<i>Patricia Nguyen</i> (Primary Examiner) (Date)				O.G. Print Claim(s)		O.G. Print Fig.	
1		7									

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	28	31	61	91	121	151
2	2	29	32	62	92	122	152
3	3	30	33	63	93	123	153
4	4	31	34	64	94	124	154
5	5	32	35	65	95	125	155
6	6	33	36	66	96	126	156
7	7	34	37	67	97	127	157
8	8	35	38	68	98	128	158
9	9	36	39	69	99	129	159
10	10	37	40	70	100	130	160
11	11	38	41	71	101	131	161
12	12	39	42	72	102	132	162
13	13	40	43	73	103	133	163
14	14	41	44	74	104	134	164
15	15	42	45	75	105	135	165
16	16	43	46	76	106	136	166
17	17	44	47	77	107	137	167
18	18	45	48	78	108	138	168
19	19	46	49	79	109	139	169
20	20	47	50	80	110	140	170
21	21	48	51	81	111	141	171
22	22	49	52	82	112	142	172
23	23	50	53	83	113	143	173
24	24	51	54	84	114	144	174
25	25	52	55	85	115	145	175
26	26	53	56	86	116	146	176
27	27	54	57	87	117	147	177
28	28	55	58	88	118	148	178
29	29	56	59	89	119	149	179
30	30	57	60	90	120	150	180